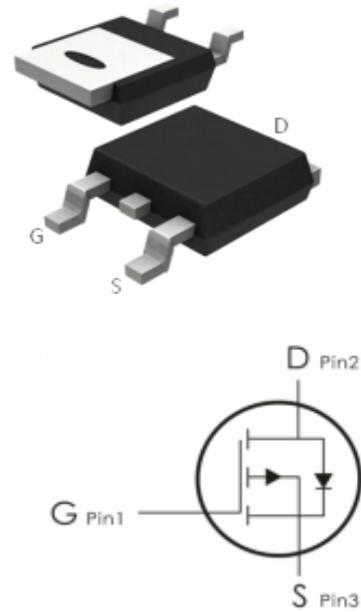


## Description:

This P-Channel MOSFET uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge. It can be used in a wide variety of applications.

## Features:

- 1)  $V_{DS}=-100V, I_D=-12A, R_{DS(ON)}<200m\ \Omega @V_{GS}=-10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra  $R_{DS(ON)}$ .
- 5) Excellent package for good heat dissipation.



## Absolute Maximum Ratings: ( $T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	-100	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current- TC=25 $^\circ C$	-12	A
	Continuous Drain Current-TC=100 $^\circ C$	-6.5	
$I_{DM}$	Drain Current – Pulsed <sup>1</sup>	-40	
$P_D$	Power Dissipation-TC=25 $^\circ C$	54	W
	Power Dissipation – Derate above 25 $^\circ C$	0.43	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55-+150	$^\circ C$

## Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance,Junction to Case	2.3	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance,Junction to Ambient	62	

## Package Marking and Ordering Information:

Part NO.	Marking	Package
DH200PG	H200P	TO-252

## Electrical Characteristics: ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu A$	-100	---	---	V
	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ $I_D=-1mA$	---	---	---	$V/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=-100V$ $T_J=25^\circ\text{C}$	---	---	-1	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=-250\ \mu A$	-1	---	-3	V
$R_{DS(ON)}$	Drain-Source On Resistance	$V_{GS}=-10V, I_D=-5A$	---	170	200	m $\Omega$
		$V_{GS}=-4.5V, I_D=-2A$	---	190	230	
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-25V, V_{GS}=0V, f=1MHz$	---	1419	2500	pF
$C_{oss}$	Output Capacitance		---	89	170	
$C_{rss}$	Reverse Transfer Capacitance		---	45	90	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=-50V, I_D=-5A,$ $R_{GEN}=25\ \Omega, V_{GS}=-10V$	---	18	36	ns
$t_r$	Rise Time		---	8	16	ns
$t_{d(off)}$	Turn-Off Delay Time		---	100	200	ns
$t_f$	Fall Time		---	30	60	ns
$Q_g$	Total Gate Charge	$V_{GS}=-10V, V_{DS}=-80V,$	---	20	40	nC

<b>Q<sub>gs</sub></b>	Gate-Source Charge	I <sub>D</sub> =-5A	---	3.5	7	nC
<b>Q<sub>gd</sub></b>	Gate-Drain "Miller" Charge		---	4.6	9	nC
<b>Drain-Source Diode Characteristics</b>						
<b>V<sub>SD</sub></b>	Source-Drain Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A, T <sub>J</sub> =25°C	---	---	-1.2	V
<b>I<sub>S</sub></b>	Diode Forward Current		---	---	-12	A
<b>T<sub>rr</sub></b>	Reverse Recovery Time <sup>2</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =-5A , di/dt=100A/μs T =25°C	---	26.6	---	NS
<b>Q<sub>rr</sub></b>	Reverse Recovery Charge <sup>2</sup>		---	24.2	---	NC

### Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
3. Essentially independent of operating temperature.

**Typical Characteristics:** (T<sub>C</sub>=25°C unless otherwise noted)

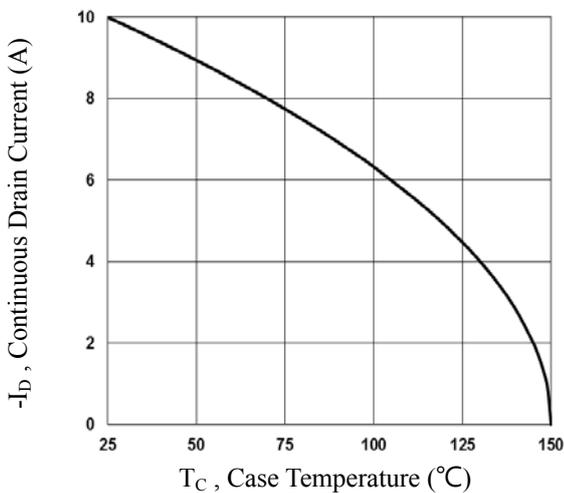


Fig.1 Continuous Drain Current vs. T<sub>C</sub>

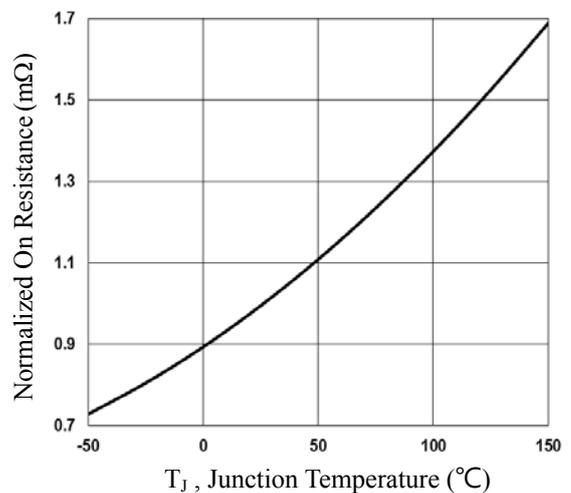


Fig.2 Normalized RDSON vs. T<sub>J</sub>

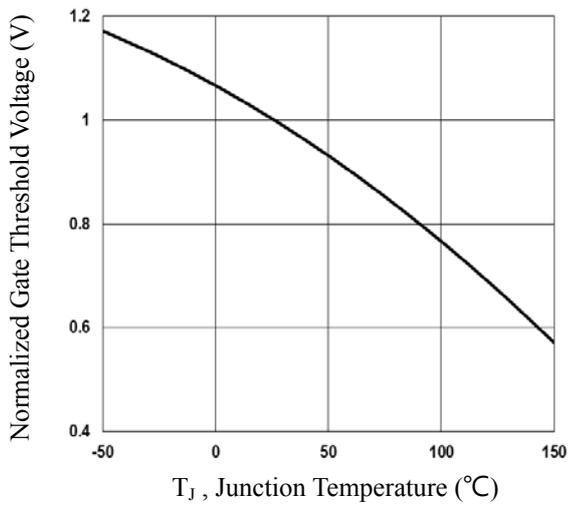


Fig.3 Normalized  $V_{th}$  vs.  $T_j$

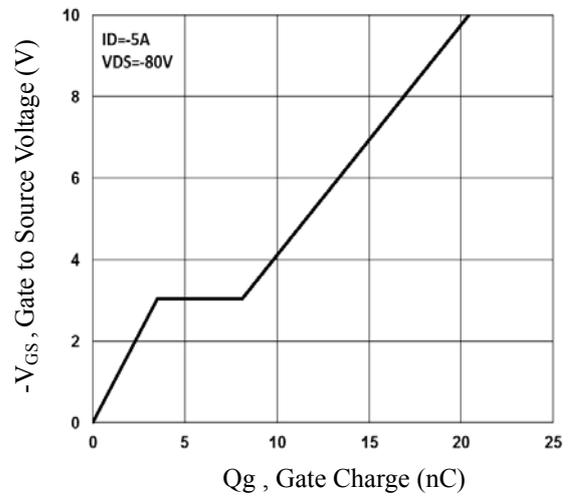


Fig.4 Gate Charge Waveform

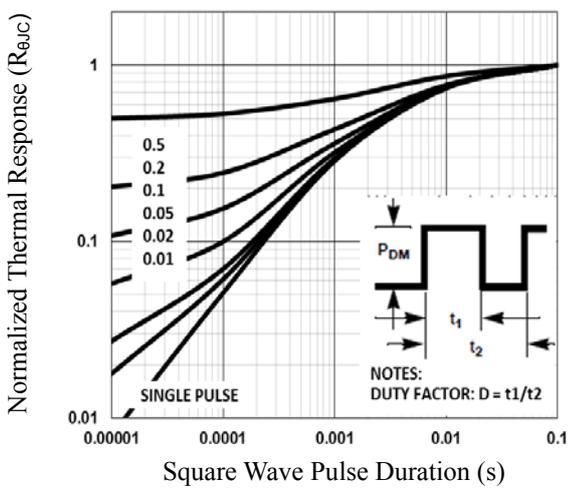


Fig.5 Normalized Transient Impedance

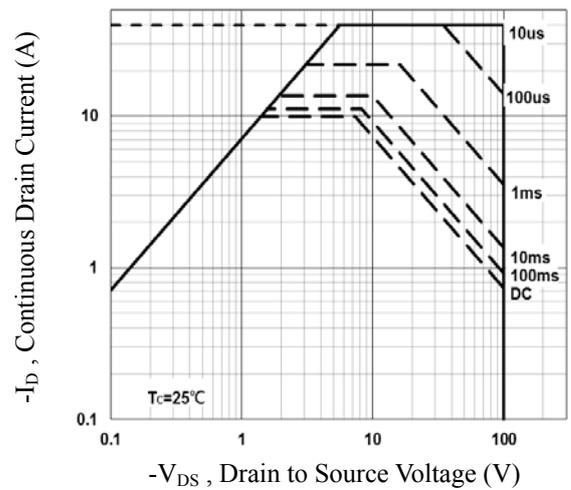


Fig.6 Maximum Safe Operation Area